xpress Mail No.		

Atty. Docket No.: 4717-7900

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Olivier RAYSSAC Confirmation No.

Application No: Group Art Unit:

Filing Date: Examiner:

For: METHOD FOR TREATING A SEMICONDUCTOR MATERIAL FOR SUBSEQUENT BONDING

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, Virginia 22313-1450

Sir:

Pursuant to applicants' duty of disclosure under 37 C.F.R. 1.56, enclosed is a PTO form 1449 which lists (5) cited references for the Examiner's review and consideration. It is respectfully requested that these references be made of record in this application by the Examiner's completion and return of the PTO Form 1449.

No fee or certification is believed to be due for this submission since the references are being submitted concurrent with the filing of this application. Should any fees be required, however, please charge such fees to **Winston & Strawn** Deposit Account No. 50-1814.

Respectfully submitted,

Date: 10/29/03

Allan A. Fanucci

Reg. No. 30,256)

WINSTON & STRAWN LLP CUSTOMER NO. 28765

(212) 294-3311

Enclosures

					ATTY. DOCKET NO.:	APPLICATION	APPLICATION SERIAL NO.:		
LIST OF REFERENCES CITED BY APPLICANT				4717-7900					
				CANT	APPLICANT:				
(Use several sheets if necessary)					Olivier RAYSSAC				
					FILING DATE:	GROUP:			
					October 30, 200				
			U.S.	PATENT DOCU	MENTS	·	_	,	
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME		CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	AA	6,180,496 B1	1/2001	Farrens et al.		438	455		
	AB	2002/0014407 A1	2/2002	Allen et al.		204	298.36		
	AC	2002/0139772 A1	10/2002	Fenner		216	60		
	AD								
	AE								
	AF								
			FORE	ZIGN PATENT DOO	CUMENTS				
		DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUBCLASS	TRANSLATION	
		DOCUMENT NOVIDER	DATE					YES	NO
	AG	WO 99/10927	3/1999	wo				X	
	АН	WO 01/61743	8/2001	WO				Х	
	AI								
		OTHER RI	EFERENCES (I	ncluding Author, T	itle, Date, Pertinent Pa	ges, Etc.)			
	AJ								
	AK								
	AL								-
:	AM								
EXAMINER DATE CONSIDERED									
*EXAMINE	ER: Init	ial if reference considered of considered. Include con	, whether or not	citation is in confo	rmance with MPEP 60	9; Draw line th	rough citation	if not i	n
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